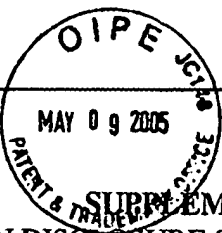| FORM PTO-1449 (REV. 7-80)	US. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 134166-1	SERIAL NO. 10/706,767

OIPE MAY 0 9 2005

SUPPLEMENTAL
INFORMATION DISCLOSURE STATEMENT BY APPLICANT
LIST OF ITEMS

Applicant Peter Micha Sandvik et al.	
Filing Date 11/12/2003	Group 2855

U.S. PATENT DOCUMENTS & U.S. PATENT APPLICATION PUBLICATIONS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MC	A1	5,362,975	11/8/94	von Windheim et al.			
	A2	5,698,771	12/16/97	Shields et al.			
	A3	6,278,133	8/21/01	Harris et al.			
	A4	US2004/0112764	6/17/05	Stokes et al.			
	A5						
	A6						
	A7						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
MC	B1	DE 100 32 062	1/24/02	Germany			X
	B2						
	B3						

OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, etc.)

MC	C1	J. Schalwig et al., *"Gas Sensitive GaN/AlGaN-Heterostructures"*, Elsevier, Sensors and Actuators, B87, pp. 425-430, 2002.
	C2	J. Schalwig et al., *"Group III-Nitride-Based Gas Sensors for Combustion Monitoring"*, Elsevier, materials Science and Engineering, B93, pp. 207-214, 2002..
	C3	Shinji Nakagomi et al., *"MISiC-FET Devices With Bias Controlled Baseline and Gas Response"*, IEEE International Conference on Sensors, Volume 2, pp. 1168-1173, 2003.
	C4	A. Loyd Spetz et al., *"MISiCFET Sensor Arrays for On Line Diagnosis"*, IEEE International Conference on Sensors, Volume 2, pp. 1124-1125, 2003.
	C5	PCT International Search Report dated February 7, 2005.
	C6	

EXAMINER	DATE CONSIDERED 3-10-06

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant